

**Search Notes**

Application/Control No.

10/539,716

Examiner

Huyen Le

Applicant(s)/Patent under  
Reexamination

HATRICK-SMITH ET AL.

Art Unit

3751

**SEARCHED**

Class	Subclass	Date	Examiner
4	541.1- 541.6	11/19/2009	HL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR